

Failure modes and degradation rates from field-aged crystalline silicon modules

Tony Sample

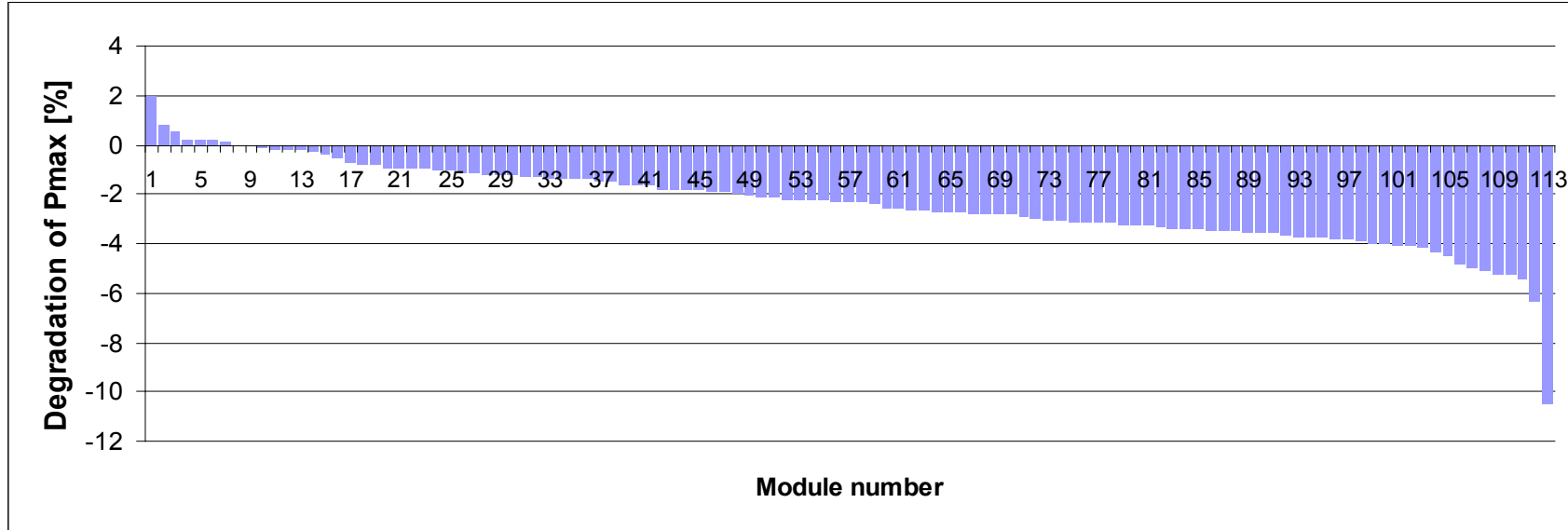
European Commission, DG JRC, Institute for Energy, Ispra, Italy

This presentation does not contain any proprietary or confidential information.

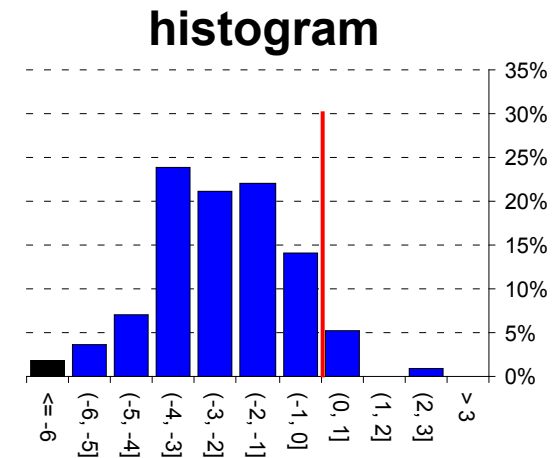
What we would like to know

- The **Degradation Mechanisms**.
 - One such source is the initial photon degradation related to a physical process in the solar cell itself, **short term**.
 - Other sources are related to **long term** weathering and degradation of the module package.
- The **Degradation Rates**. In order to understand the effect and relevance of each of these mechanisms on the total energy production of a PV module or array over its life time.
- The **Life Expectancy**. With this Life expectancy and knowledge of the degradation rates we can define the total energy output per lifetime of a PV module or array.

- During an IEC 61215 test procedure there is the requirement to perform an outdoor exposure (OE) test of 60kWh solar irradiance in short circuit conditions.
- At the JRC ESTI laboratory 113 module types have been subjected to this test.
- Degradations observed range from zero to -6.3% with a correlation between the P_{max} degradation and the I_{sc} degradation.
- The average degradation observed is **2.4%** with deviation of $\pm 1.7\%$.



Summary of the degradation in P_{max} after the Outdoor Exposure Test for 113 module types tested at JRC Ispra.

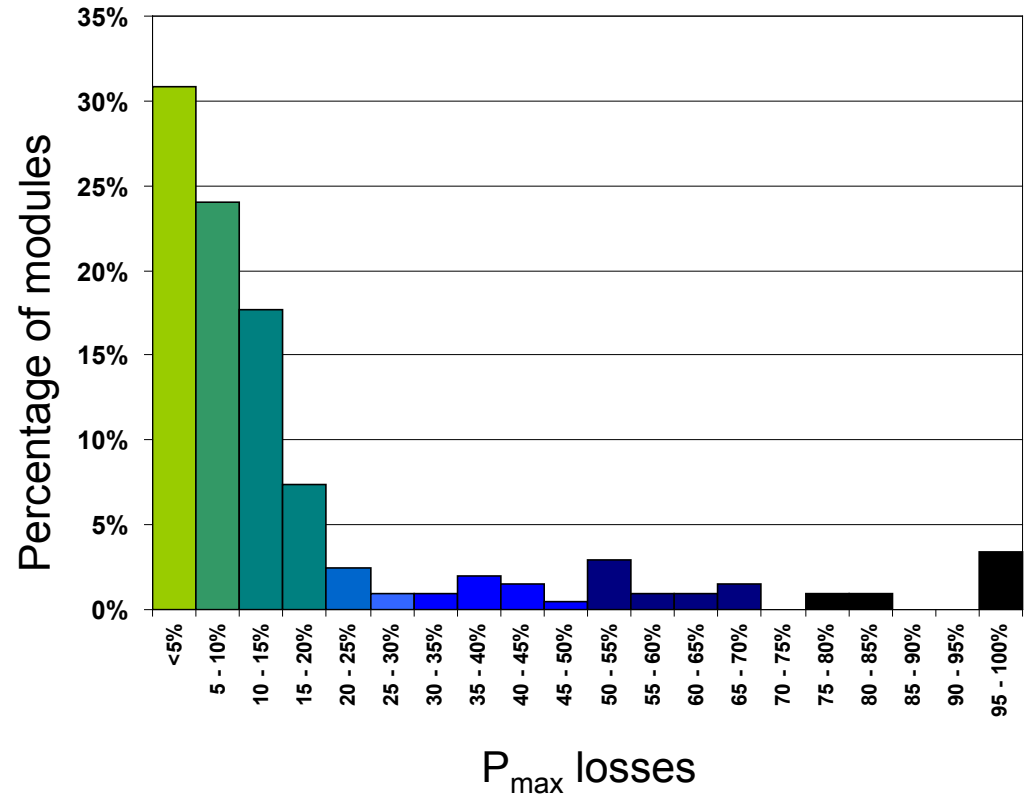
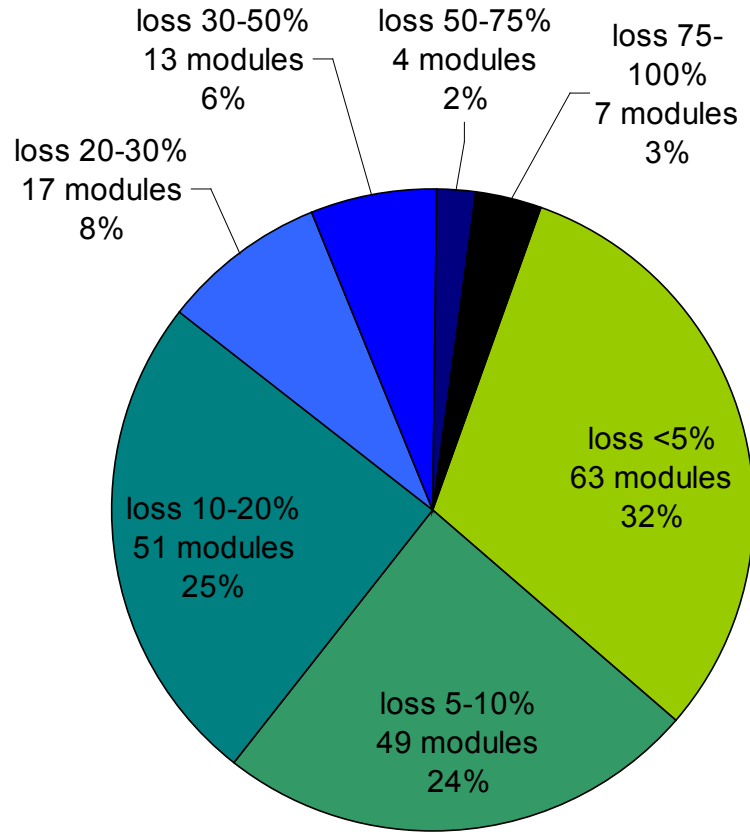




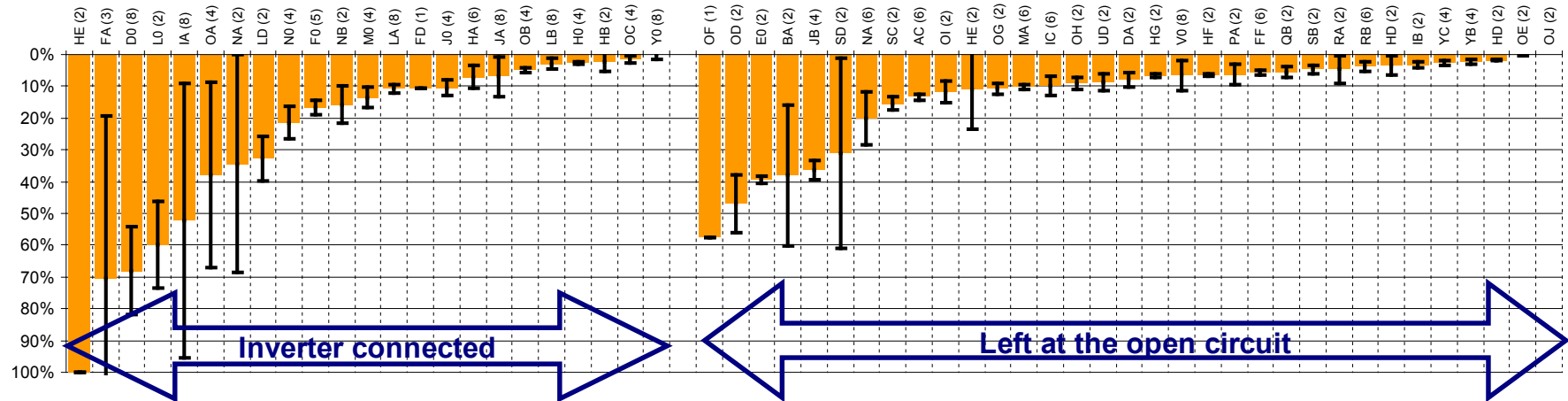
Long-term (18 - 24 years) outdoor exposure

Location: Ispra - moderate subtropical (-10°..+35°, >90% RH)

No of modules		204
No of producers		20
No of module types		53
Cell type	Mono	123
	Poly	81
Encapsulant	PVB	59
	Silicone	40
	EVA	101
	Other (unknown)	4
Substrate / Backsheet	Glass	68
	Tedlar, Tedlar/Aluminium/Tedlar	62
	Tedlar/Aluminium/Polyester	8
	Polyester/Aluminium	20
	Silicone	20
	Others, polyethylene, "plastic" Unknown	26



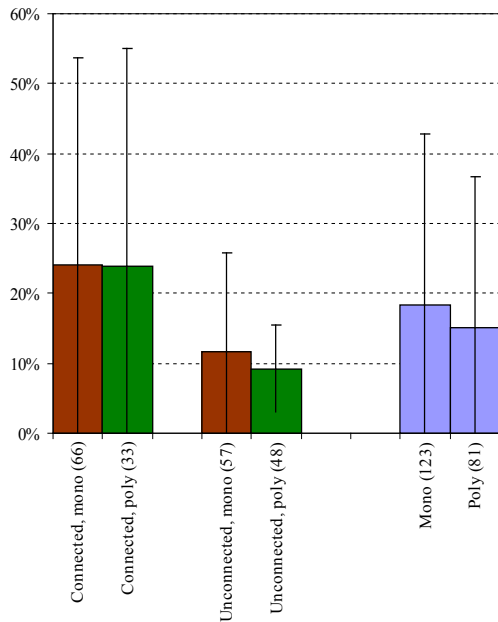
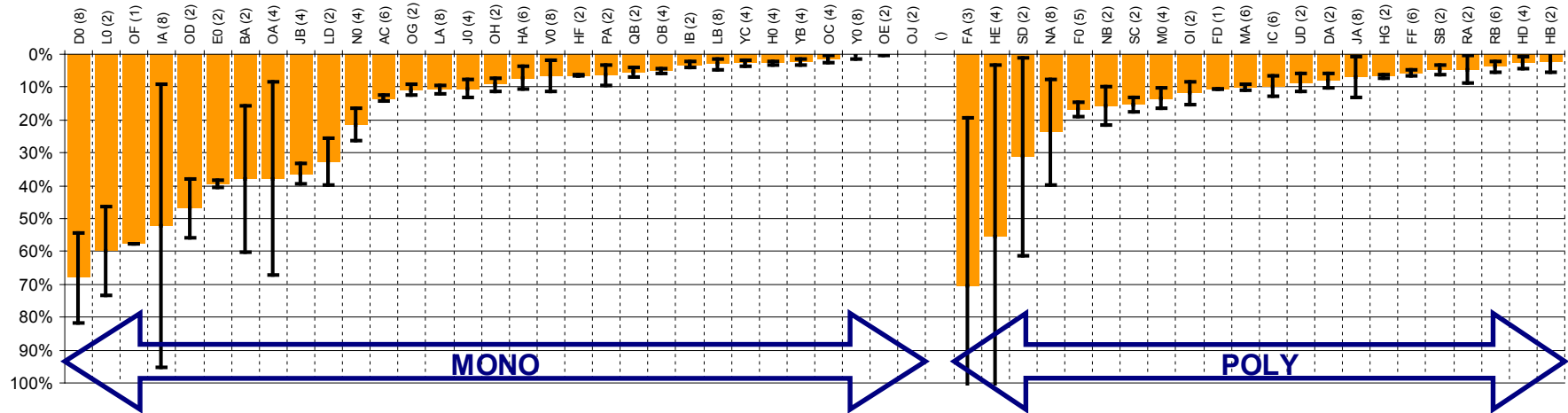
Relative P_{max} losses of modules series grouped by module's test conditions



A statistical difference between modules initially connected to the inverter (charger) which exhibited approximately twice the average degradation in comparison to modules left in open circuit.

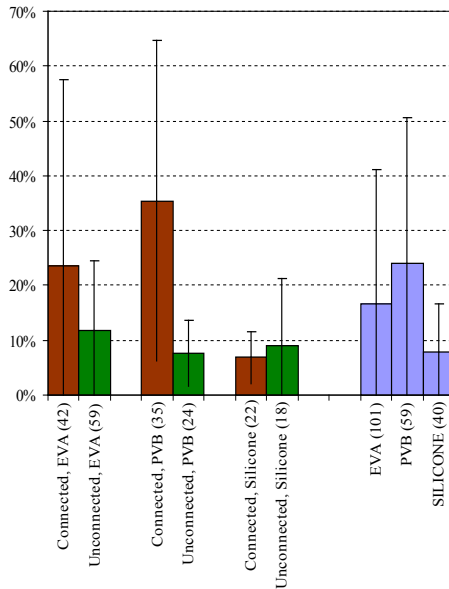
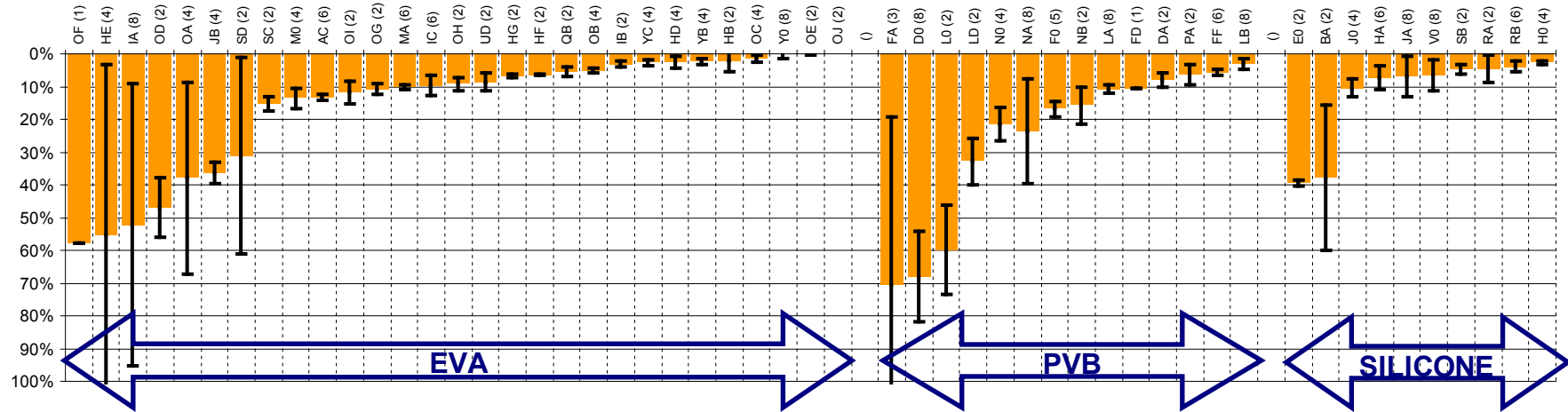
All of the modules (7) which exhibited total circuit breakage were connected to the inverter.

Relative P_{max} losses of modules series grouped by cell technology



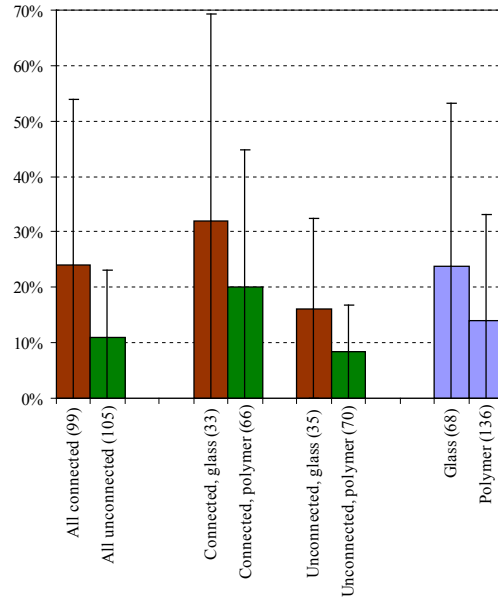
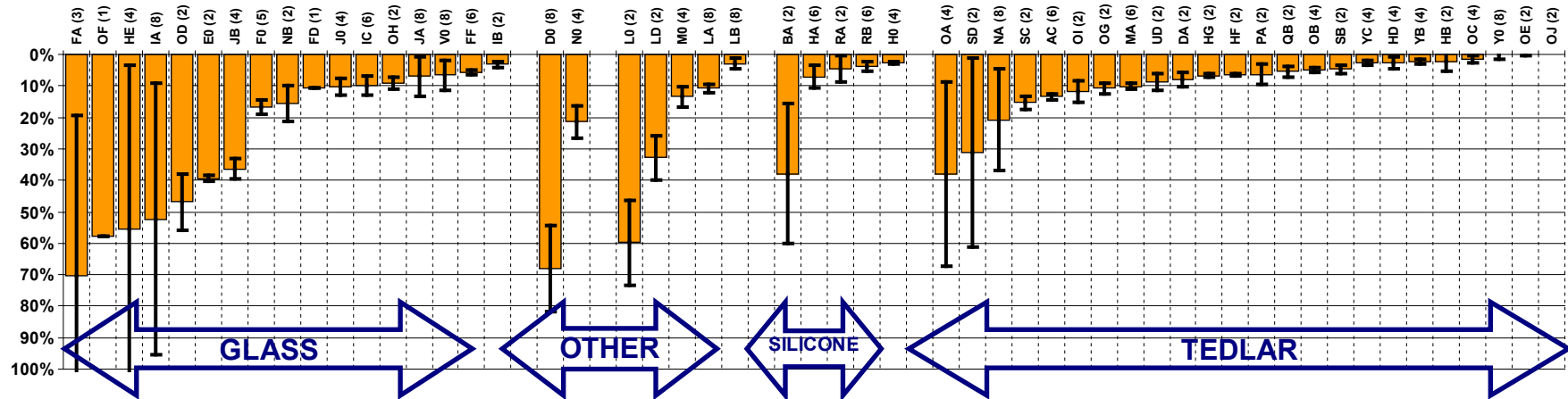
No statistical difference between modules incorporating monocrystalline or polycrystalline cells

Relative P_{max} losses of modules series grouped by encapsulant



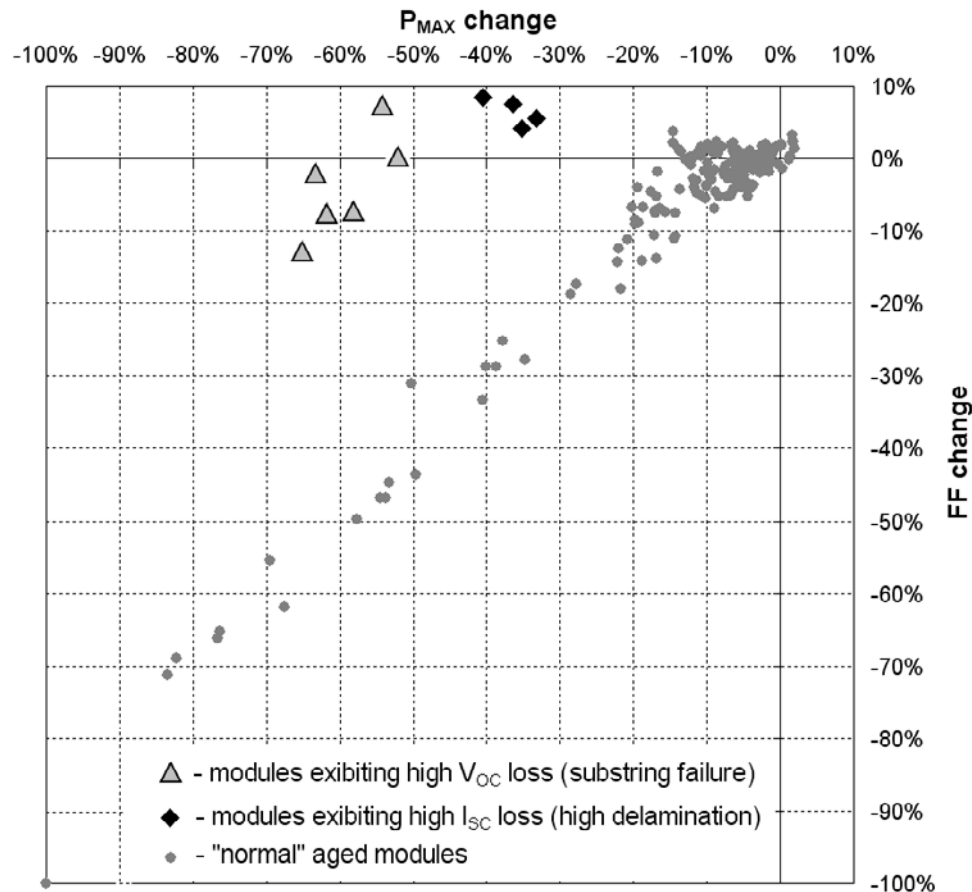
Modules incorporating silicone encapsulation generally exhibited lower degradation

P_{max} losses of modules series grouped by back sheet



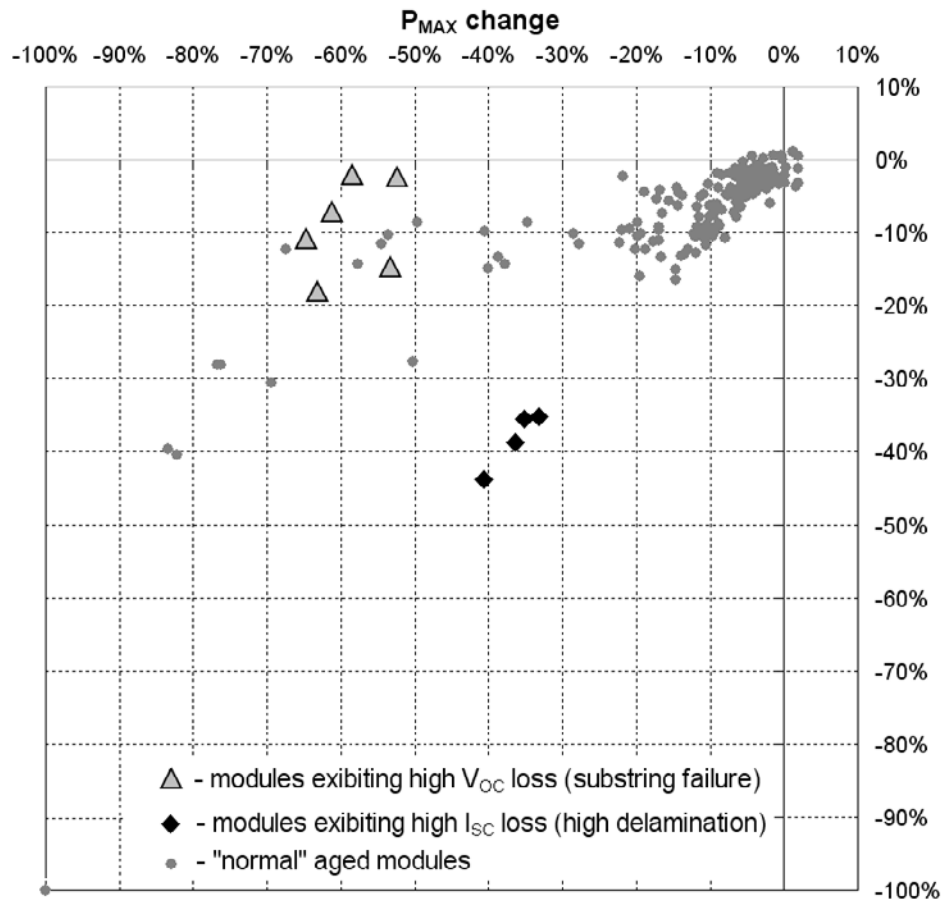
Glass-glass modules generally exhibited a greater degradation than glass-polymer construction

The scatter plot of the dependence of the P_{MAX} losses on the FF losses



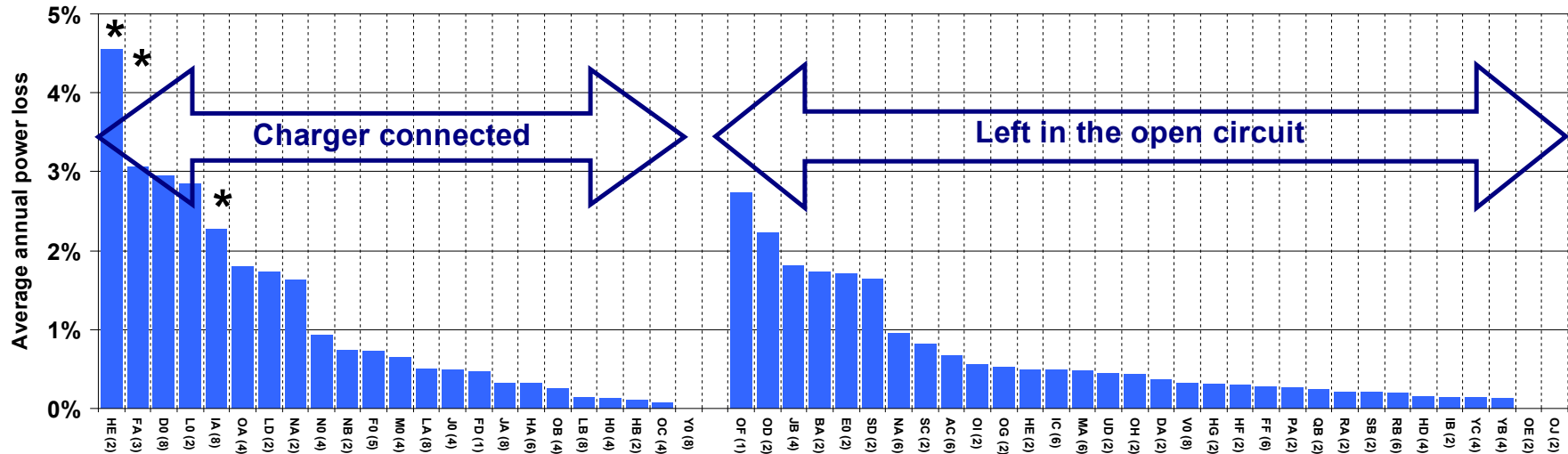
Generally high P_{max} losses (>20%) are attributed to FF losses (series resistance increase)

The scatter plot of the dependence of the P_{MAX} losses on the I_{SC} losses



Moderate P_{max} losses (<20%) can be attributed to I_{sc} losses (optical properties degradation)

- Changes in optical transmittance (glass or encapsulant)
- Delamination
- Light induced boron-doped silicon degradation

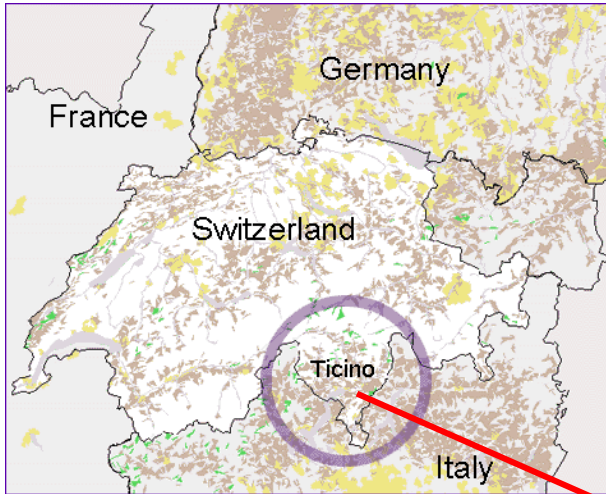


* Average including total failures

The average annual degradation for all of the connected modules **1%** (0.8% excluding total failures)

The average annual degradation for all of the modules left in open circuit **0.6%**

- No statistical difference between mono or polycrystalline cells
- Glass-glass modules generally exhibited a greater degradation than glass-polymer construction
- Modules incorporating silicone encapsulation generally exhibited lower degradation
- Generally high P_{\max} losses (>20%) are attributed to FF losses (series resistance increase)
- Moderate P_{\max} losses (<20%) can be attributed to I_{sc} losses (optical properties degradation)
- A statistical difference between modules initially connected to the inverter (charger) which exhibited approximately twice the average degradation in comparison to modules left in open circuit.
- The average annual degradation for all of the connected modules **1%** (0.8% excluding total failures)



252

(12 strings of 21 panels each)

Arco Solar

ASI 16-2300 modules

35 m-Si cells, PVB encapsulant, Tedlar/Al/Tedlar backsheet

Arco Solar, ASI 16-2300 m-Si Module power @STC: 37Wp

Construction

Monocrystalline cells, PVB Encapsulant, Tedlar/Aluminium/Tedlar backsheet

Initial Configuration 1982

288 Modules (24 strings of 12) (nominal 10.66 kWp)

200V operation (Abacus 10kW inverter)

Tilt array 65°

Present Configuration since 1992

252 Modules (12 strings of 21) (nominal 9.32 kWp)

± 350 V operation (Ecopower 15kW inverter)

Tilt array 55°

1982: Initial aim

- To study technical and safety problems of a PV plant connected to the grid

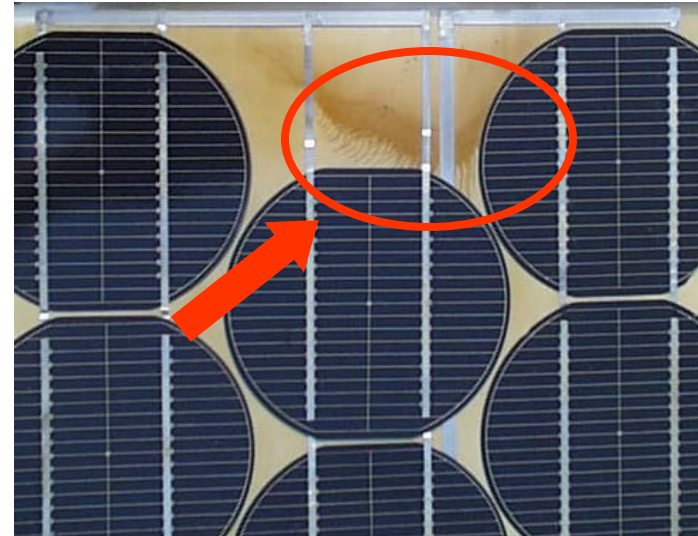
2000-2003:

- Plant aging
- Investigation of physical degradation mechanisms
- Field reliability/accelerated lifetime tests (CEI/IEC 61215) correlation

- Detailed visual inspection
- InfraRed analysis
- Indoor IV measurements
 - reference modules
 - all modules
- Repeated CEI/IEC 61215 Damp heat and Thermal Cycling

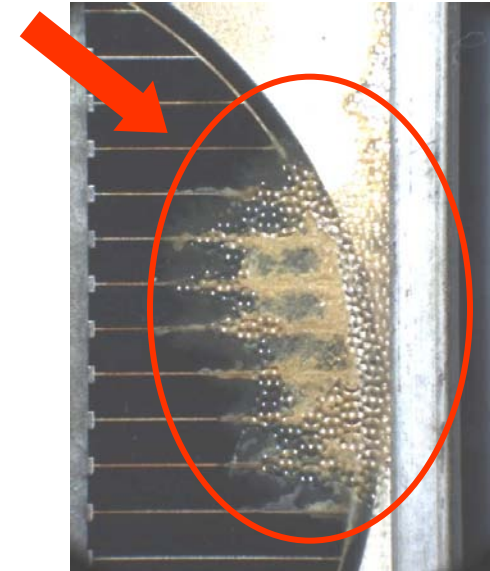
Visual defects: yellowing

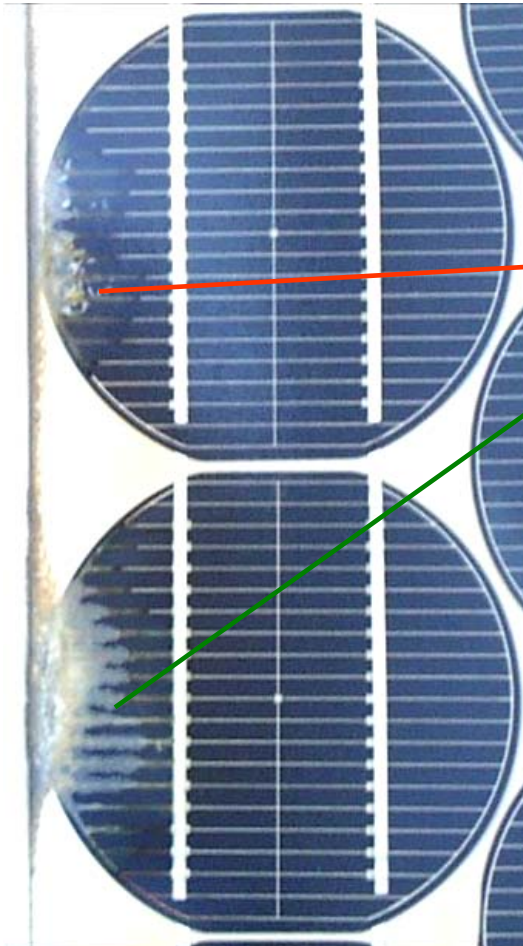
- 98% of modules (2003)
(~50% in 1985)
- 78% exhibiting complete coverage of module
(63% dark yellowing)
- Darker spots
- Practically no influence on encapsulant transparency
(same spectral response for white and yellow modules)



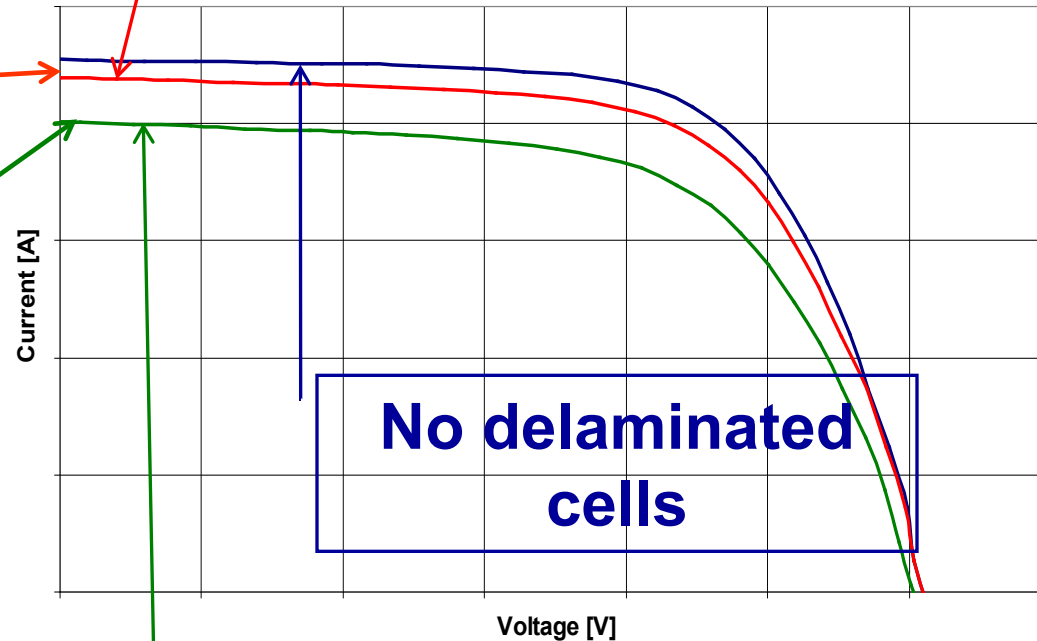
Visual defects: delamination

- 92% of modules
(74% in 1996)
- 27% major defect
according to IEC 61215
- No effects on modules insulation
(dry & wet insulation tests)
- Effects on modules performance
(delamination in front of cells)
(cumulative total delaminated area)





Delaminated area: 3.0%
 ΔP_{max} : -6.5%, ΔI_{sc} : -3.4%



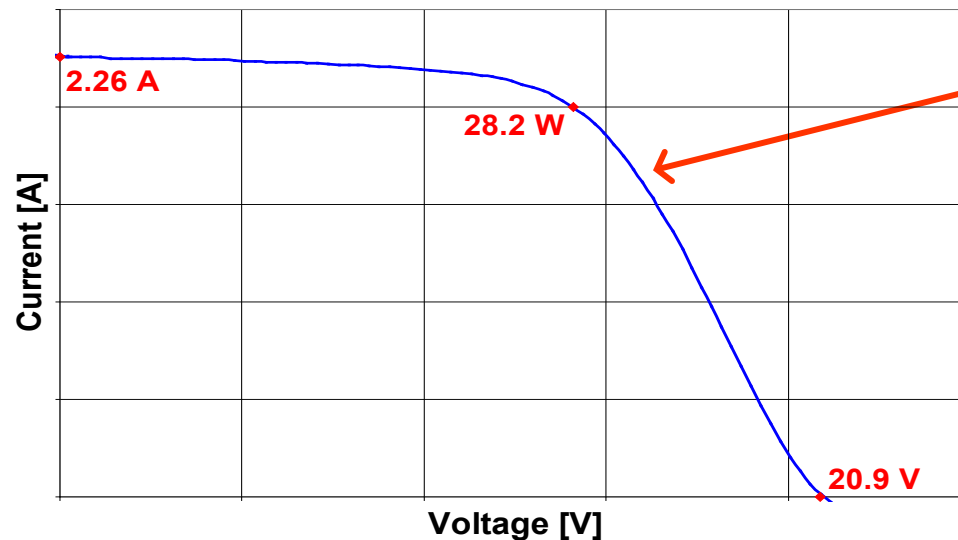
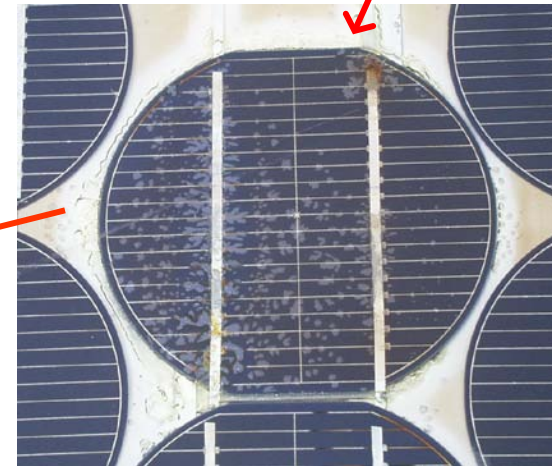
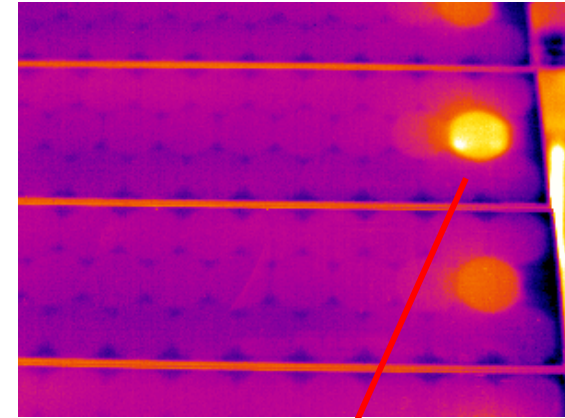
Delaminated area: 8.3%
 ΔP_{max} : -18.3%, ΔI_{sc} : -11.7%

No great effect on module performance

- Sealant infiltration
76% of modules
- Cracked cells
15% of modules
- Browning (oxidation) of gridlines
- Poor Junction box seal to backsheet tedlar
risk of detachment; bad insulation
- Terminal oxidation
problems when wiring



- Noticeable Hot-spots: 24% of modules (22% in 1999)
(Not just the effect of the junction box)
- Most degraded modules worst P_{max} : -29% vs P_n



**P_{max} : -24% vs P_n
(-15% vs average actual P_{max})**

- **18 modules reference modules**

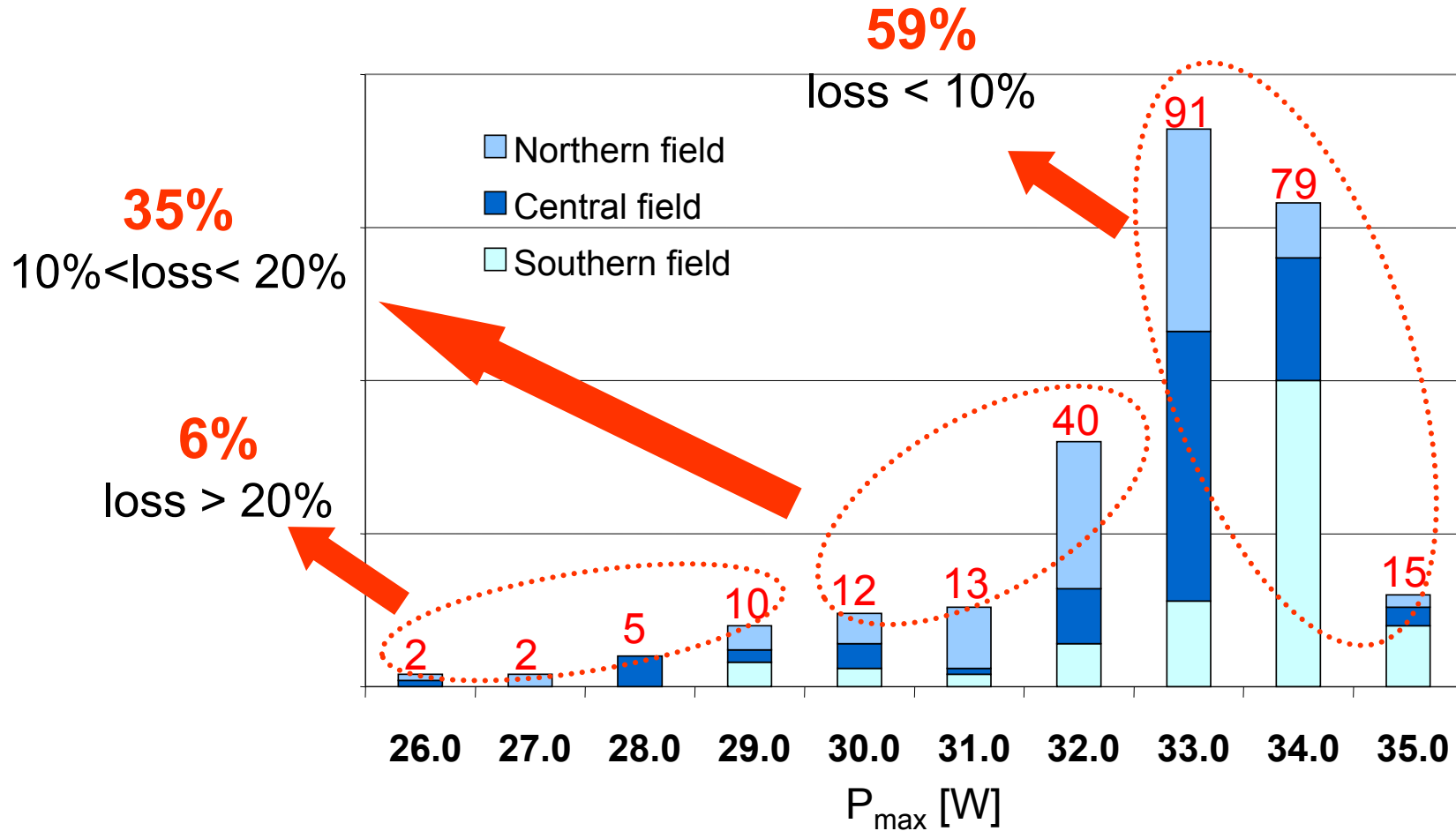
ESTI laboratory IV measurements - since 1982

- **13 stable modules**

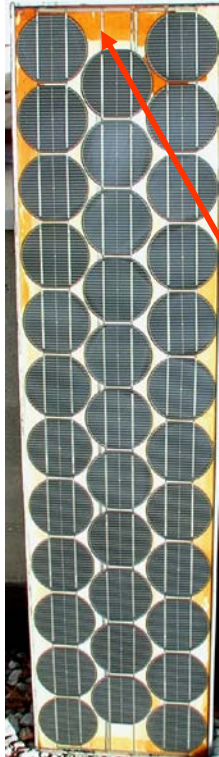
power loss: -1.7% vs 1982 mean P_{\max}

- **5 degraded modules**

power loss: **-9.1%** vs 1982 mean P_{\max}
(2 hot-spot, 1 damaged cell)

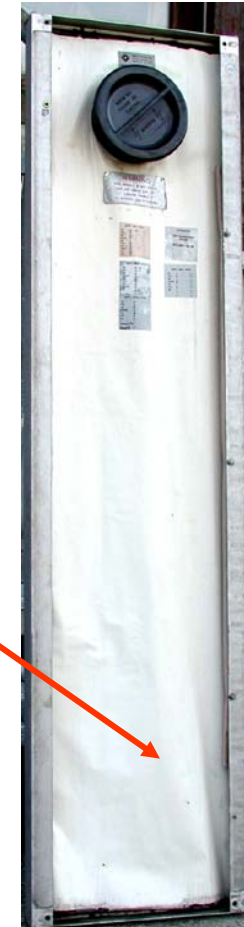


Original Nominal Module power @STC: 37Wp



- 1220 Thermal Cycles:
no major defects
no measurable power losses
- 6000 hours Damp Heat:
dark yellowing
detachment of tedlar backsheet
(not observed outside)
no measurable power losses

Observed delamination outdoor, not reproduced through indoor tests



- **Good 20-year old technology**
- Not good looking, but perfectly functioning plant
- Hot-spots
- Delamination
- Remarkable modules resistance of old modules to repeated indoor Damp Heat and Thermal Cycling
- Good expectation for at least 30 year lifetime?

Currently at 29 years and still working well!

Detailed analytical data of the progressive degradation of PV modules is not readily available.

Realini et. al. For a crystalline silicon array, with Arco Solar ASI 16-2300 modules. Indicates an average weighted degradation of 5.2%. Over the 19 years of operation or **0.3% per annum** including initial degradation.

Reis et. al. For a crystalline array, with Arco Solar M-75 modules. The array was installed in 1990 and indicates a degradation of 4.39% in 11 years or **0.4% per annum** including initial degradation.

Osterwald et al. Stated rates of between **0.5 and 0.8% per annum** (shorter term experiments which linked to total UV dose to degradation in I_{sc})

Granata et al. Concluded that only one of the eight arrays studied showed true power degradation beyond experimental error at **1.4 0.8% per annum**

“Comparison of PV module performance before and after 11-years of field Exposure” AM Reis, et al . Proceedings of the 29th IEEE PVSEC, New Orleans, USA, 2002; 1432–1435.

“Degradation analysis of weathered crystalline-silicon PV modules” C.R. Osterwald, et al Proceedings of the 29th IEEE PVSEC, New Orleans, USA, 2002; 1432–1435.

“Long-term performance and reliability assessment of 8 PV arrays at Sandia National Laboratories” J.E. Granata, et al. Proceedings of the 34th IEEE PVSEC, Philadelphia, USA, 2009; 1486–1491.

Short Term Losses: have been shown to be in the order of **2.4% ± 1.7%**.

Long Term Losses: have been shown to in the order of 0.2% per annum up to 1% per annum.

May be skewed data towards low degradation rates, due to the types of systems studied

The effect on **Energy Life** can result in losses in the order of ~5% up to ~8% based on a 20 year operation.

Over the module lifetime this is dominated by the long term losses.

The ESTI laboratories module qualification team past and present

Artur Skoczek, Mike Field and Ewan Dunlop

Antonella Realini (LEEE-TISO)

The work was partially funded by the PERFORMANCE project of the European Commission under contract number SES-019718 within FP6.

